

engineering data service

5977

MECHANICAL DATA

Bulb																					T-3	
Base			٠.					E8	-10,	Sı	ubn	nin	iat	ure	Bu	ttc	n F	lex	cibl	e I	Leads	
Outl	ine																		JE.	ſΕ	C 3-1	
Basir	ng		٠														٠.	<u>.</u>	:		8DK	
Cath	.ode	: .													(Joa	ted	Uı	nıp	ote	ential	
Mou	ntii	ng	Pos	iti	on																Any	
RAT	ING	S'	(A	\bs	olu [.]	le l	Ma	xim	um)												
	Imp	acı	tΑ	cce	ler:	atio	on														450	G
1	Unî	for	m.	Aco	ele	rat	ioi	ı.													1000	G
	Fat:	igu	e (Vil	orat	ioi	nal	Ac	cele	ra	tio	n f	or									
		E:	x te	nde	d F	eri	od	s)													2.5	G
	Bul																				220°	C
	Alt:																			8	30000	Ft.

ELECTRICAL DATA

HEATER CHARACTERISTICS

				Min.	Bogey	Max.
Heater Voltage ³				6.0	6.3	6.6 V
Heater Current					150	mA

DIRECT INTERELECTRODE CAPACITANCES

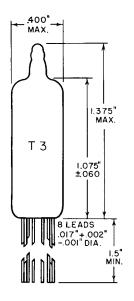
Grid to Plate 1.3 1.3 μμf Input 2.0 2.0 μμf Output 2.2 0.8 μμf RATINGS¹ * 5 (Absolute Maximum) Plate Voltage 180 Vdc Peak Plate Forward Voltage6 360 v Plate Dissipation 3.3 W Plate Current 22 mAdc Grid Current 4.4 mAdc DC Grid Voltage 70 Vdc
Input
Input
Output 2.2 0.8 μμf RATINGS ^{1 x 5} (Absolute Maximum) Plate Voltage 180 Vdc Peak Plate Forward Voltage ⁶ 360 v Plate Dissipation 3.3 W Plate Current 22 mAdc Grid Current 4.4 mAdc DC Grid Voltage Positive Value 0 Vdc
RATINGS ^{1 * 5} (Absolute Maximum) Plate Voltage
Plate Voltage
Plate Voltage
Peak Plate Forward Voltage 6
Plate Dissipation
Plate Current
Grid Current
DC Grid Voltage Positive Value 0 Vdc
Positive Value 0 Vdc
Positive Value 0 Vdc
Negative Value
Heater-Cathode Voltage
Heater Positive with Respect to Cathode 200 v
Heater Negative with Respect to Cathode 200 v
Grid Circuit Resistance
CHARACTERISTICS
Plate Voltage
Cathode Resistor
Amplification Factor
Transconductance 4500 μmhos
Grid Voltage for Ib = $100 \mu Adc Max13.5 Vdc$

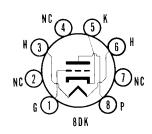
NOTES:

- 1. Limitations beyond which normal tube performance and tube life may be impaired.
- 2. If altitude rating is exceeded, reduction of instantaneous voltages (Ef excluded) may be required.
- 3. Tube life and reliability of performance are directly related to the degree of regulation of the heater voltage to its center rated value of 6.3 volts.
- 4. External shield of 0.405 inch diameter connected to cathode.
- 5. Values shown are as registered with RETMA.
- 6. Per MIL-E-1C Par. 6.5 and General Section of this Sylvania Subminiature Tube Manual titled Specifications and Ratings.

QUICK REFERENCE DATA

The Premium Subminiature Type 5977 is a relatively high perveance medium mu triode intended for a variety of applications: power amplifier driver, blocking oscillator, multivibrator and Class C amplifier. It is designed for operation under conditions of severe shock, vibration, high temperature and high altitude. The 5977 is manufactured and inspected to meet the applicable MIL-E-1 specification for reliable operation.





SYLVANIA ELECTRIC PRODUCTS INC.

RADIO TUBE DIVISION EMPORIUM, PA.

Prepared and Released By The TECHNICAL PUBLICATIONS SECTION EMPORIUM, PENNSYLVANIA

FEBRUARY 1957

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ACCEPTANCE CRITERIA

Test Conditions

Heater Voltage 6.3 V Heater-Cathode Voltage MIL-E-1 Par. 3.2.2.1 . 0 V
Plate Voltage 100 Vdc
Grid Voltage 0 V

For the purposes of inspection, use applicable reliable paragraphs of MIL-E-1 and Inspection Instructions for Electron Tubes.

MIL-E-I		401	ĺ					
Ref.	Test	AQL (%)	Min.	LAL	Bogey	UAL	Max.	Units
/leasuremo	ents Acceptance Tests, Part I, Note I							
.1.1.7 .10.8	(Method A) Heater Current: ALD = 12	_	_	144	150	156	_	mA
1.10.8	Heater Current:	0.65	140	_	_	_	160	mA
.10.15	Heater-Cathode Leakage: Ehk = +100 Vdc Ehk = -100 Vdc.	0.65 — —	_ _ _	_ _ _	<u>-</u>		5.0 5.0	μAdc μAdc
1.10.6.1	Grid Current: Rg = 1.0 Meg	0.65	0	_	_	_	-0.4	μAdc
1.1.7 1.10.4.1	(Method A) Plate Current (1): ALD = 3.4	_	_	8.9	10.0	11.1	_	mAdc
.10.4.1	Plate Current (1):	0.65	7.0	–	_		13.0	mAdc
.10.4.1	Plate Current (2): Ec = -13.5 Vdc; Rk = 0 Ohms	0.65		_	_		100	μAdc
.1.1.7 .10.9	(Method A) Transconductance (1): ALD = 900 Sm			4200	4500	4800	_	μ mhos
.10.9	Transconductance (1): Sm	0.65	3700		_		5300	μ mhos
.7.5	Continuity and Shorts (Inoperatives):	0.4		_	_		_	
.9.1	Mechanical: Envelope (8-1)	_			_	1	_	
Measureme	ents Acceptance Tests, Part 2							
1.8.2	Insulation of Electrodes: g-all. p-all.	2.5 — —	100 100	_ 	_ _ _	-	_ 	Meg Meg
.10.9	Transconductance (2): $\triangle _{Ef.}^{Sm}$	2.5	-	_	_	_	15	%
.10.6.2	Grid Emission: Note 4 Ef = 7.5 V; $Ec = -13.5 Vdc$; $Rg = 1.0 Meg$; $Rk = 0 Ohms$	2.5	0	_		_	-0.5	μAdc
.10.3.2	AF Noise: Esig = 40 mVac; Ec = -4 Vdc; Rg = 0.1 Meg; Rp = 0.01 Meg; Rk = 0 Ohms	2.5	_	_		_	17	VU
.10.11.1	Amplification Factor:	6.5	13.5	-	16.0	_	18.5	
	Pulse Emission: Notes 6 and 7 Ef = 6.0 V; e pulse = 50 v; tp = 25 μsec; prr = 200 pps	6.5	300		;			 .
10.14	Capacitance:	6.5		_	_	_		ma
.10.14	No Shield Cgp No Shield Cin No Shield Cout		1.0 1.5 0.6			_ _ _	1.6 2.5 1.0	μμf μμf μμf
.9.12.1	Low Pressure Voltage Breakdown: Pressure = 20 ±5 mm Hg.; Voltage = 300 Vac	6.5			_	_		

ACCEPTANCE CRITERIA (Continued)

		401			Limits			
MIL-E-I Ref.	Test	AOL (%)	Min.	LAL	Bogey	UAL	Max.	Units
Measureme	ents Acceptance Tests, Part 2 (Continued)							
4.9.20.3	Vibration (1): No Voltages; Post Shock and Fatigue Test End Points Apply	10.0	_		_			
4.9.19.1	Vibration (2): $Rp = 10,000 \text{ Ohms}$; $Ck = 1000 \mu f$; $F = 40 \text{ cps}$; $G = 15$	2.5	_	_	_	_	50	mVac
4.9.19.1	White Noise: Note 5 Rp = 10,000 Ohms; $Ck = 1000 \mu f$; Peak Acceleration = 15 G	2.5 2.5	_ _	_ _	<u> </u>	_ 	200 30	mv pk-pk mVac
Degradation	on Rate Acceptance Tests, Note 2							
4.9.5.3	Subminiature Lead Fatigue:	2.5	_	4	_	-	–	arcs
4.9.20.5	Shock: Hammer Angle = 30° ; Ehk = $+100 \text{ Vdc}$; Rg = 0.1 Meg	20		_		_		
4.9.20.6	Fatigue: G = 2.5; Fixed Frequency; F = 25 min., 60 max	6.5	_	_	_	_	_	
	Post Shock and Fatigue Test End Points: Vibration (2) Heater-Cathode Leakage			_			200	mVac
	Ehk == +100 Vdc Ehk = -100 Vdc	=	<u> </u>	_	<u> </u>	<u>-</u>	20 20	μAdc μAdc
	Change in Transconductance (1) of Individual Tubes	_	_			_	20	%
4.9.6.3	Glass Strain:	6.5		_	_	_	_	

				Defectives acteristic	Lin	-		
MIL-E-I Ref.	Test	AQL (%)	lst Sample	Combined Samples	Min.	Max.	Units	
Acceptance	e Life Tests, Note 2							
4.11.7	Heater Cycling Life Test: Ef = 7.0 V; 1 min. on, 4 min. off; Ehk = 140 Vac; Ec = Eb = O V	2.5	_	-	_	_		
4.11.3.1	Stability Life Test: (1 Hour) Ehk = +200 Vdc; Rg = 1.0 Meg; TA = Room	1.0	_	_	_	_		
1.11.4	Stability Life Test End Points: Change in Transconductance (1) of Individual Tubes	_	***************************************			10	%	
1.11.3.1 1.11.3.1.1	Survival Rate Life Test: (100 Hours). Stability Life Test Conditions or Equivalent; TA = Room		_					
.11.4	Survival Rate Life Test End Points: Continuity and Shorts (Inoperatives) Transconductance (1) Sm	0.65 1.0	<u>-</u>	_	3300		μmhos	
1.11.5 1.11.3.1	Intermittent Life Test: Note 3 Stability Life Test Conditions; T Envelope = +220°C min.; 1000 Hour Requirements Do Not Apply	_	-		_	_		

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ACCEPTANCE CRITERIA (Continued)

		AQL (%)	Aliowable per Char	Lin			
MIL-E-I Ref.	Test		lst Sample	Combined Samples	Min,	Max.	Units
 Acceptanc	e Life Tests, Note 2 (Continued)						
4.11.4				1			
4.11.3.1	Intermittent Life Test End Points:						
1.22.7.2	(500 Hours)						
	Inoperatives		1	3		_	
	Heater Current	_	2	3 5	138	164	mA.
i	Grid Current	_	1	3	0	-1.0	μAdc
	Change in Transconductance (1) of					İ .	
	Individual Tubes $\triangle_{\pm}^{\text{Sm}}$	_	1	3		20	%
	Transconductance (2) \triangle_{Ef}^{Sm}	_	2	5	_	15	%
	Heater-Cathode Leakage	_	2	5			
	Ehk = +100 Vdc	_ '		_		10	μAdc
	Ehk = -100 Vdc	_			_	10	μAdc
	Insulation of Electrodes	_	2	5	_	_	
- 1	g-all		_	_	50	—	Meg
	p-all		_	_	50	-	Meg
	Transconductance (1) Average Change, Avg	_	_	_	_	15	%
	Total Defectives		4	8	_		

ACCEPTANCE CRITERIA NOTES:

- 1: The AQL for the combined defectives for attributes in Measurements Acceptance Tests, Part 1, excluding inoperatives and mechanical shall be one (1) percent. A tube having one (1) or more defects shall be counted as one (1) defective.
- 2: Tubes subjected to the following destructive tests are not to be accepted under this specification.

4.9.5.3 Subminiature lead fatigue

4.9.20.5 Shock

4.9.20.6 Fatigue

4.11.7 Heater cycling life test

4.11.5 Intermittent life test

- 3: Envelope temperature is defined as the highest temperature indicated when using a thermocouple of \$\%40\$ BS or smaller diameter elements welded to a ringe of 0.025 inch diameter phosphor bronze placed in contact with the envelope. Envelope temperature requirement will be satisfied if a tube, having bogey Ib (±5%) under normal test conditions, is determined to operate at maximum specified temperature at any position on the life test rack.
- 4: Prior to this test tubes shall be preheated five (5) minutes at conditions indicated below. Test within three (3) seconds after preheating. Three-minute test is not permitted. Grid Emission shall be the last test performed on the sample selected for the Grid Emission Test.

Ef	Ec	Eb	Rk	Rg
V	Vdc	Vdc	Ohms	Rg Meg
7.5	0	100	270	1.0

5: The tube shall be rigidly mounted on a table vibrating such that the instantaneous values of acceleration shall constitute approximately a "White Noise" spectrum which is free from discontinuities from 100 cps to 5000 cps. The spectrum of instantaneous acceleration shall be such that each octave of bandwidth delivers 2.3 G's rms acceleration. With this the case, the rms value of acceleration for any bandwidth within the specified spectrum is equal to

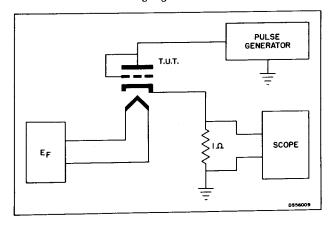
G rms = 2.3 G
$$\sqrt{3.32 \log_{10} (f2/f1)}$$

f2 and f1 are the upper and lower frequencies, respectively, of the band under consideration. The degree of clipping of the peak ac-

celerations shall be such that the peak value of acceleration is at at least 15 G's.

The voltage (ep) produced across the resistor (Rp) as a result of vibration shall be coupled through a compensating amplifier to a low pass filter. The compensating amplifier shall have a high input impedance (0.25 megohm or more) and shall be adjusted to compensate for any insertion losses in the filter. The combined frequency response of amplifier and filter shall be flat within ± 0.5 db from 50 cps to 8000 cps, shall be down no more than 5 db at 10,000 cps and at 20 cps, and down at least 40 db at 13,000 cps. For reading the peak to peak value of output voltage the filter output shall be fed directly to the input of a Ballantine Model 305 peak to peak electronic voltmeter or equal, while the rms value shall be measured with a Hewlett-Packard Model 400C or equal.

- 6: Test each section separately.
- 7: The pulse is essentially a square wave with 1.0 µsec rise time and 0.8 µsec fall. The pulse shall be applied to plate and grid tied together. Pulse emission shall be measured in terms of voltage developed across a 1.0 ohm resistor in the cathode circuit. Test limit as measured by the leading edge of a calibrated oscilloscope trace, the amplitude of the trailing edge of which shall not vary by more than 20 percent from the value of the leading edge.



APPLICATION DATA

The Premium Subminiature Type 5977 is a medium mu triode having relatively high perveance. It is especially well suited to a wide variety of low frequency applications. These include resistance coupled amplifiers, sync clippers, blocking oscillators and multivibrators. Resistance coupled amplifier data is shown in the accompaning table and circuit. Its ability to handle large signals also lends the tube to power amplifier driver applications.

The 5977 may also be used as a uhf oscillator or Class C amplifier. A curve of power output vs frequency at a constant input of 3.3 watts is shown in Figure 1 for oscillator service. Figure 2 shows the variation of input resistance with frequency.

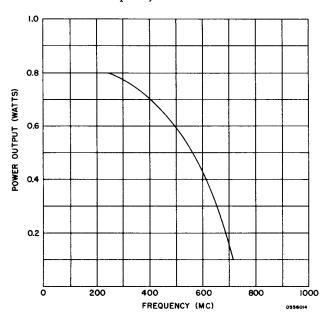


Figure 1—Oscillator performance curve

Electrically, the 5977 is similar to the 6AK4. The 5977, however, is manufactured and inspected to meet the applicable MIL-E-1 specification and is intended for operation under severe conditions of vibration, shock, high temperature and high altitude.

To insure correlation with actual field conditions and thereby enhance equipment reliability, vibrational noise output is controlled by the "white noise test" as shown in the acceptance criteria. Briefly, this test consists of subjecting the tubes to a white noise vibration spectrum covering the frequency band of 100 to 5000 cps at a rms level of 2.3 g's per octave and a peak level of 15 g's.

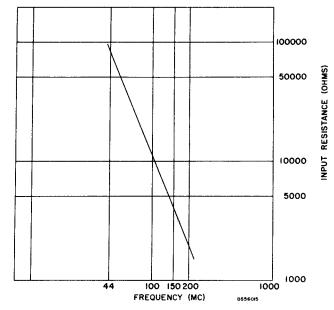


Figure 2-Input resistance vs frequency

Limits are shown for both peak and rms output. A further discussion of the white noise vibrational test is included in the frontal section of this manual.

Life expectancy is described by the life tests, specified on the attached pages and/or individual MIL-E-1 specifications. The actual life expectancy of the tubes in an operating circuit is affected by both the operating and environmental conditions involved. Likewise, the life tests specified indicate performance under certain operating criteria to a set of specified end points. Performance at conditions other than those specified can usually be estimated only roughly as giving better or poorer life expectancy. For further discussion of life expectancy, reference should be made to the frontal section of this manual.

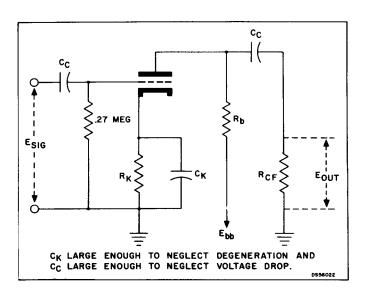
To insure optimum performance in pulse applications this type is subjected to a pulse emission test as shown in the accompaning data. The tube must, under the specified pulse operating conditions, deliver a minimum specified current. A further discussion of this test is included in the frontal section of this manual.

When operated under conditions common to on-off control applications the tube exhibits freedom from the development of interface resistance. The heater-cathode construction is designed to withstand intermittent operation.

RESISTANCE COUPLED AMPLIFIER DATA

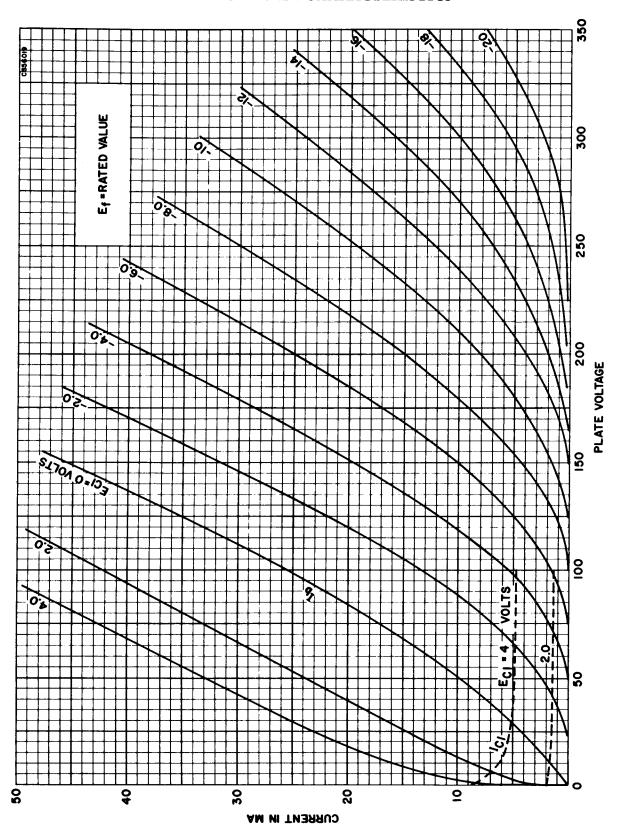
			Ebb ==	100 Volts					Ebb ==	200 Volts		
Rb (megohms)	0.047		0.10		0.27		0.047		0.10		0.27	
Rcf (megohms) Rk (ohms) Ib (ma) Ec (volts) Eb (volts)	2200 1.11 -2.44	0.27 2700 1.05 -2.84 50.6	0.10 3900 0.602 -2.35 39.8	0.47 6800 0.484 -3.29 51.6	0.27 15000 0.210 -3.15 43.3	0.47 18000 0.197 -3.55 46.8	0.10 1500 2.59 -3.88 78.4	0.27 2200 2.28 -5.02 92.8	0.10 3300 1.29 -4.26 71.0	0.47 5600 1.08 -6.05 92.0	0.27 12000 0.455 -5.46 77.0	0.47 15000 0.419 -6.29 86.8
Esig (volts, rms). Eout (volts, rms). Gain. % Distortion.	5.2 10.4	0.5 5.3 10.6 1.4	0.5 5.0 10.0 1.8	0.5 5.3 10.6 1.1	0.5 5.0 10.0 1.3	0.5 5.1 10.2 1.0	1.0 11.6 11.6 1.8	1.0 11.6 11.6 1.4	1.0 11.3 11.3 1.7	1.0 11.5 11.5 1.0	1.0 10.9 10.9 1.3	1.0 11.0 11.0 1.0
Esig* (volts, rms)	13.6 10.4	1.5 15.9 10.6 4.8	1.3 13.0 10.0 5.0	1.9 19.9 10.5 4.9	1.6 15.4 9.6 5.0	1.9 19.3 10.2 5.0	2.4 28.0 11.6 5.0	3.1 36.2 11.7 5.0	2.5 28.0 11.2 5.0	3.8 43.3 11.4 5.0	3.2 33.5 10.5 5.0	3.9 41.5 10.6 5.0

^{*}Maximum signal for 5% distortion or ½ microampere grid current.

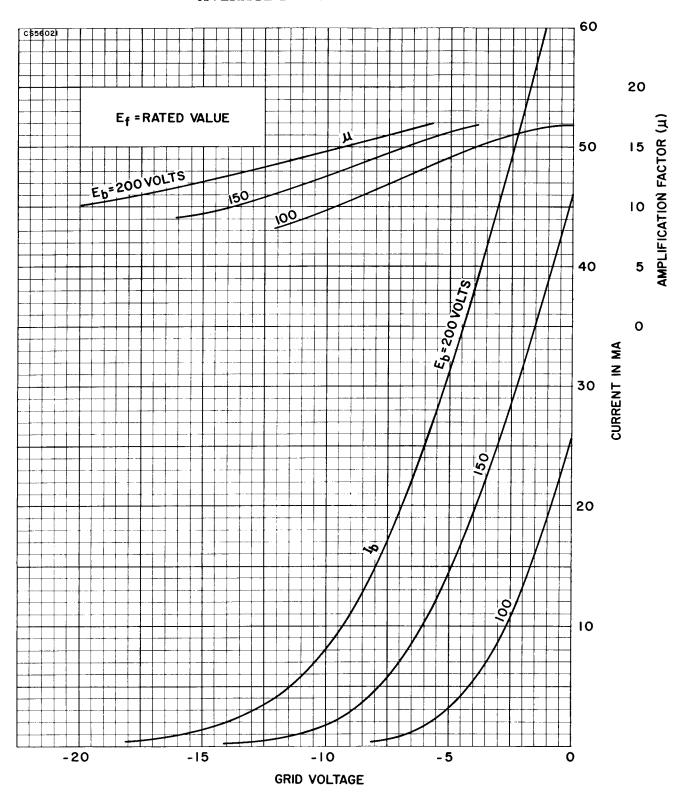


Resistance coupled amplifier circuit

AVERAGE PLATE CHARACTERISTICS



AVERAGE TRANSFER CHARACTERISTICS



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AVERAGE TRANSFER CHARACTERISTICS

